PCN Number: 20161115002 PCN Date: 11/16/2016							/2016					
Title:       Qualification of UTAC as Additional Assembly Site for Select PVQFN Package Devices												
Customer Contact: PCN Manage				er Dept: Quality Services								
Proposed 1 <sup>st</sup> Ship Date: 02/16		/16/20	17	/	imated ailabilit	Sample v:		Date Provided at Sample request				
Change Type:												
Assembly Site					Design					Wafer Bum	ip Site	
	y Process				Data S				Wafer Bump Material			
Assembly	y Material	s			Part nu	umber cl	hange			Wafer Bum	ip Proce	SS
Mechanie	cal Specifi	cation		Test Site					Wafer Fab	Site		
Packing/	Shipping/	Labeling		Test Process					Wafer Fab	Materia	ls	
					DCN	Detai				Wafer Fab	Process	
Description	of Change	21			PCN	Dela	15					
Description	or Change	8:										
Texas Instruments is announcing the qualification of UTAC as Additional Assembly Site for select devices listed in the "Product Affected" Section. Current assembly sites and Material differences are as follows.												
Assembly Site	e Assem	bly Site (	Origin		Assembl	y Countr	y Code			embly Site C		
TI Clark	QAB			F	PHL				ngeles City, Pampanga			
UTAC	NSE			1	<b>FHA</b>			Ba	ngk	ok		
Material Diff	erences:	I								1		
			TI Cla	rk	ζ.	UTAC						
Lead Finish N			NiPdA	iPdAu NiPdAuAg			J					
Mount Comp	ound		42071	07123 PZ0035								
Mold Compound 42			42086	08625 CZ0289								
Reason for C	hange:											
Continuity of	supply.											
Anticipated i	mpact or	n Form,	Fit, F	ur	nction, (	Quality	or Relia	abili	ity (	(positive /	negati	ve):
None												
Changes to product identification resulting from this PCN:												
Assembly Site TI-CLARK		<u>۸</u>	Assembly Site Origin (22L)					ASO: QAB				
UTAC				Assembly Site Origin (22L)					ASO: QAB			
Sample product shipping label (not actual product label)												
MADE IN: M 2DC: MSL 2 /260 MSL 1 /235 OPT: ITEM: LBL: 5A	ALEYSIA 20: C/1 YEAR C/UNLIM (L)TO	<sup>39</sup> :1750		1000年1000日			(4W) TK (P) (2P) Rev (20L) CS	ООО от (Y (	: 39 1T)	(D) 033 959047MLA 7523483 (V) 00333 (21L) CC0:U (23L) AC0:	A 3512 317 JSA	
ASSEMBLY SITE CODES: TI-CLARK = I , NSE = J												

Product Affected:			
CC1310F128RGZR	CC1310F32RSMT	CC2640F128RSMR	CC2620F128RGZT
CC1310F128RGZT	CC2630F128RGZR	CC2640F128RSMT	CC2620F128RSMR
CC1310F128RHBR	CC2630F128RGZT	CC1310F64RGZR	CC2620F128RSMT
CC1310F128RHBT	CC2630F128RHBR	CC1310F64RGZT	CC2650F128RGZR
CC1310F128RSMR	CC2630F128RHBT	CC1310F64RHBR	CC2650F128RGZT
CC1310F128RSMT	CC2630F128RSMR	CC1310F64RHBT	CC2650F128RHBR
CC1310F32RGZR	CC2630F128RSMT	CC1310F64RSMR	CC2650F128RHBT
CC1310F32RGZT	CC2640F128RGZR	CC1310F64RSMT	CC2650F128RSMR
CC1310F32RHBR	CC2640F128RGZT	CC1350F128RGZR	CC2650F128RSMT
CC1310F32RHBT	CC2640F128RHBR	CC1350F128RGZT	
CC1310F32RSMR	CC2640F128RHBT	CC2620F128RGZR	

## Qualification Report

## CC26xx Qualification in UTAC with F021 TSMC

Draduct Attributes

Product Attributes					
Attributes	Qual Device: CC2640F128RGZ	Qual Device: CC2640F128RSMR	QBS Device: XCC3200Z11MRGK		
Assembly Site	UTAC	UTAC	UTAC		
Package Family	QFN	QFN	QFN		
Flammability Rating UL 94 V-0		UL 94 V-0	UL 94 V-0		
Wafer Fab Supplier       TSMC FAB14		TSMC FAB14	TSMC FAB14 UMC 12A		
Wafer Fab Process F021		F021	F021 C021		

- QBS: Qual By Similarity

- Qual Device CC2640F128RGZR is qualified at LEVEL3-260C

## **Qualification Results**

Data Displayed as: Number of lots / Total sample size / Total failed

Туре	Test Name / Condition	Duration	Qual Device: CC2640F128RGZ	Qual Device: CC2640F128RSMR	QBS Device: XCC3200Z11MRGK	
CDM	ESD - CDM	250V, 500, 750V	1/3/0	-	-	
HTSL	High Temp Storage Bake 150C	1000hr	3/231/0	-	3/230/0	
PC	PreCon MSL3	3 Cyc/260C +5 / - 0C	3/904/0	3/270/0	6/721/0	
тс	Temperature Cycle, - 55/125C	700cy	3/231/0	3/231/0	3/231/0	
THB	Biased Temperature and Humidity, 85C/85%RH	1000hr	QBS	-	3/77/0	
UHAST	Unbiased HAST 110C/85%RH	264hr	3/231/0	-	3/231/0	

- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable

- The following are equivalent HTOL options based on an activation energy of 0.7eV : 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours

- The following are equivalent HTSL options based on an activation energy of 0.7eV : 150C/1k Hours, and 170C/420 Hours

- The following are equivalent Temp Cycle options per JESD47 : -55C/125C/700 Cycles and -65C/150C/500 Cycles Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

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Green/Pb-free Status:
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Qualified Pb-Free(SMT) and Green

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

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USA	PCNAmericasContact@list.ti.com
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